EFFECTIVE MATERIALS FOR HIGH FREQUENCY EMC DESIGN

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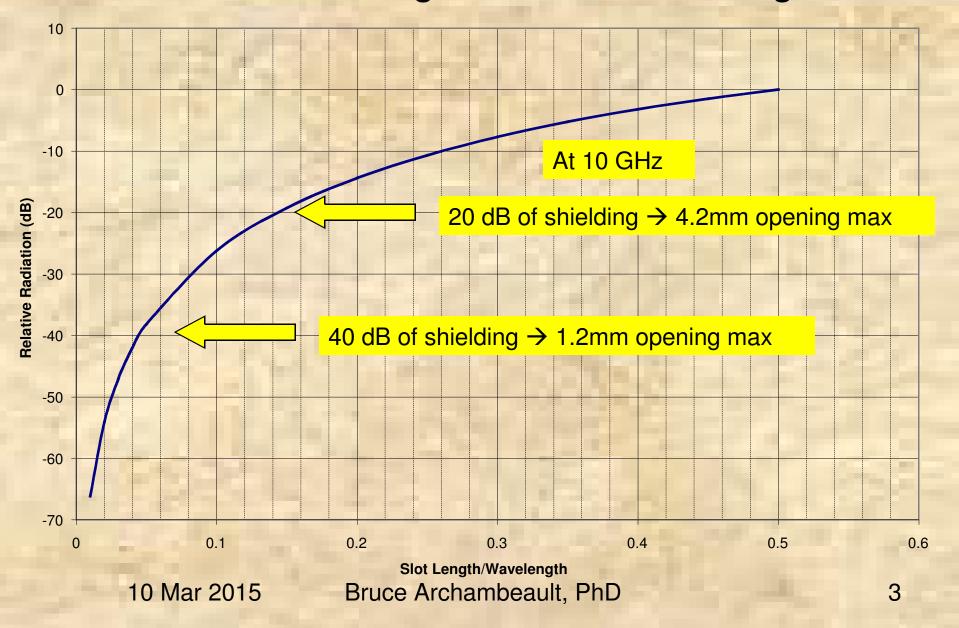
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Shielding

- One of the primary EMI control techniques
- Depends on a EM tight enclosure
 - Electrically small openings
 - Conflicts with thermal and functionality
- We are reaching the practical limit of using shielding
 - Emissions can easily occur in tens of GHz range
 - At 10 GHz, lambda = 3 cm
- How effective is a slot opening??

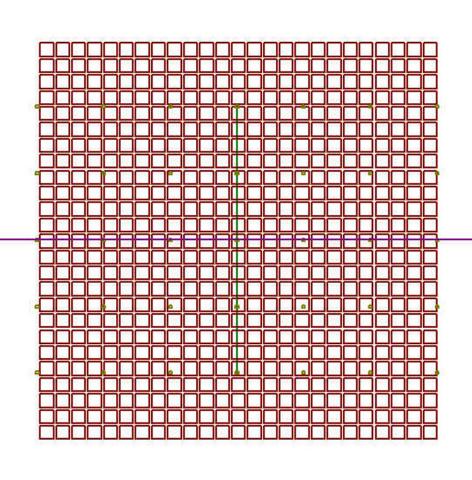
Slot Leakage vs Size and Wavelength



What Can We do to Improve Shielding?

- Reduce hole size options limited
- Add thickness to metal?
 - Honey comb air filters are effective to a certain frequency
 - Limited by wavelength
 - Expensive

Air Vent Geometry



TOTAL AREA = 15cm x 15cm

1mm spacing between holes

Hole Sizes

4mm x 4mm

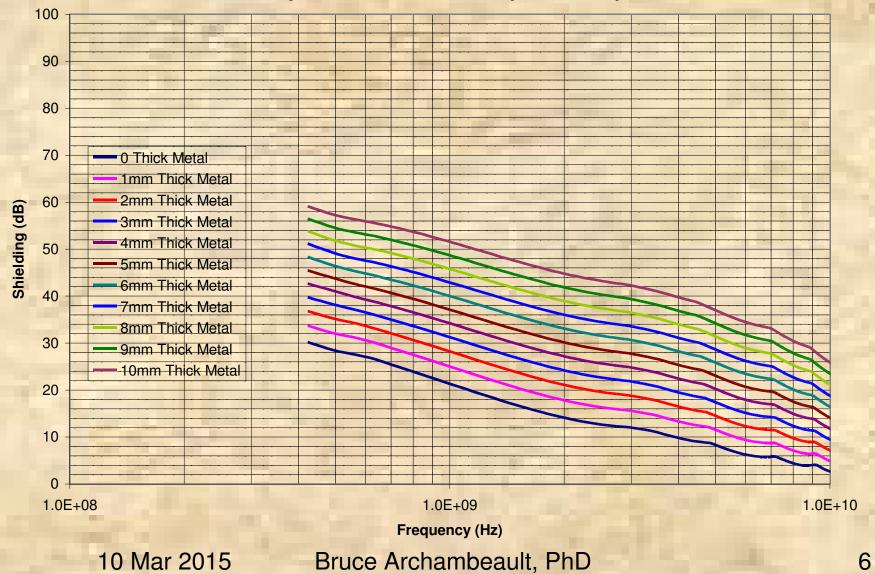
5mm x 5mm

7mm x 7mm

9mm x 9mm

Metal panel thickness varied 1 – 10mm

Shielding performance for 9x9 mm holes Array 15x15 holes = 18,225 sq mm total open



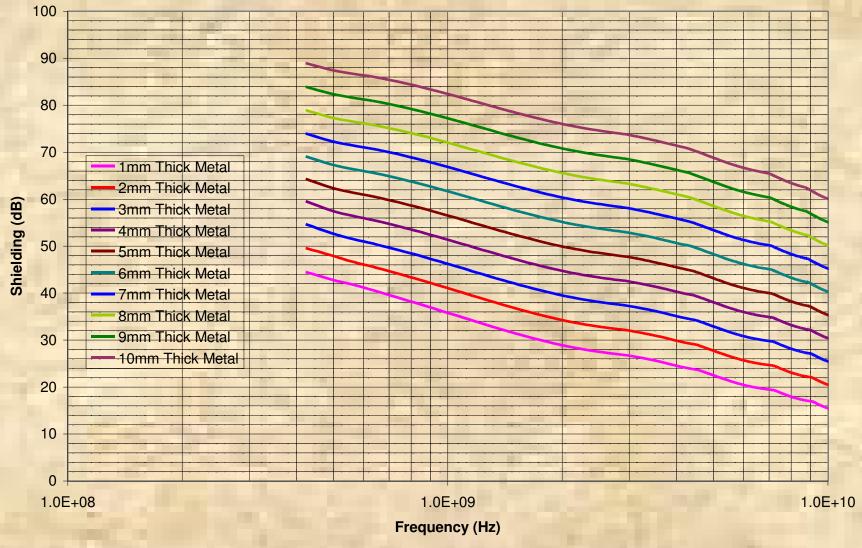
Shielding performance for 7x7 mm holes Array 18x18 holes = 15,876 sq mm total open



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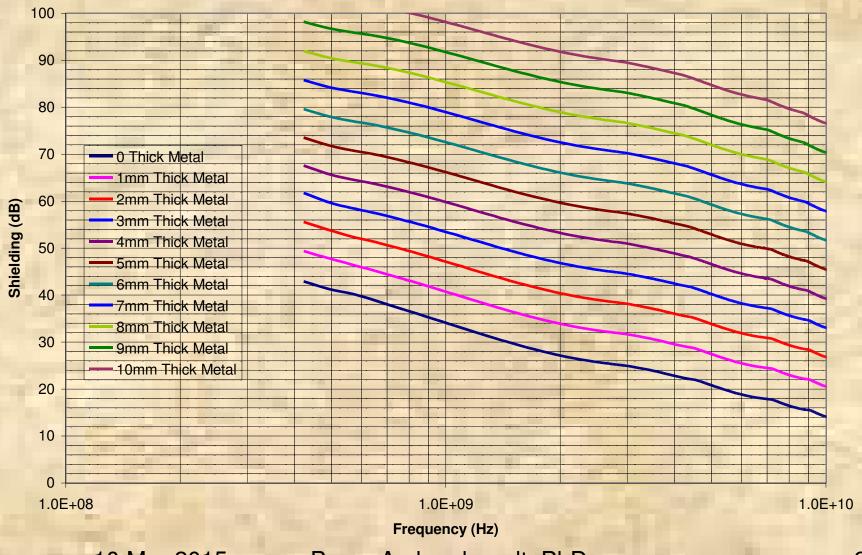
Shielding performance for 5x5 mm holes Array 25x25 holes = 15,625 sq mm total open



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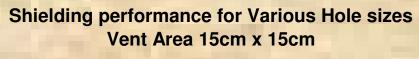
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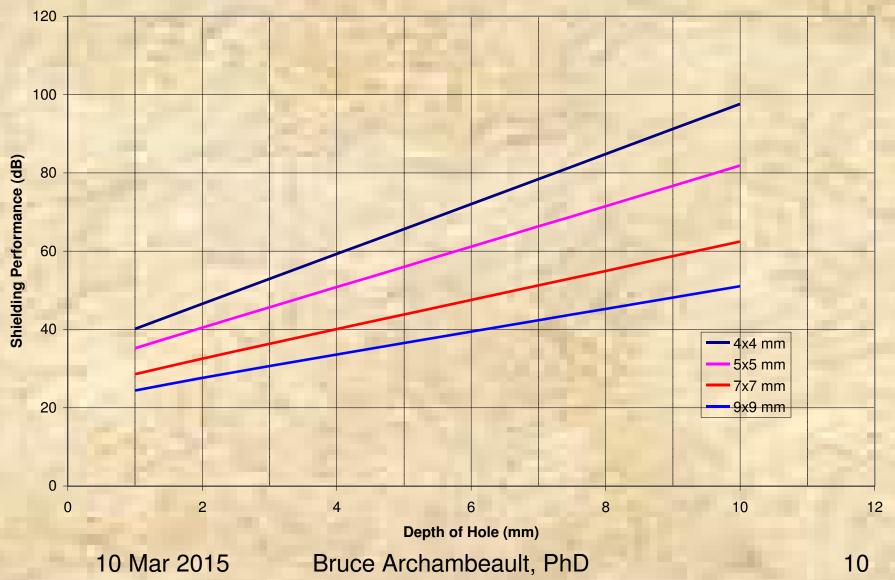
Shielding performance for 4x4 mm holes Array 30x30 holes = 14,400 sq mm total open



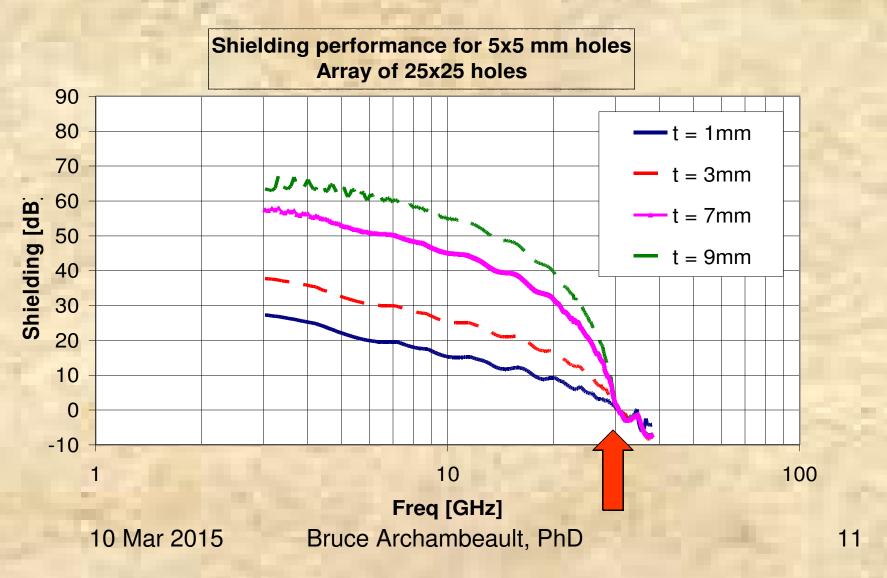
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Even additional thickness has limitations once ½ Lambda is reached



So What Now?

- When Shielding fails us.....
- And we can not reduce the energy at the source
 - Direct from the IC
 - Signals needed for proper operation
- Absorption with lossy materials is the only alternative

Material Parameters

- Sigma → electrical conductivity
- Eps → dielectric properties
- Mu → magnetic properties

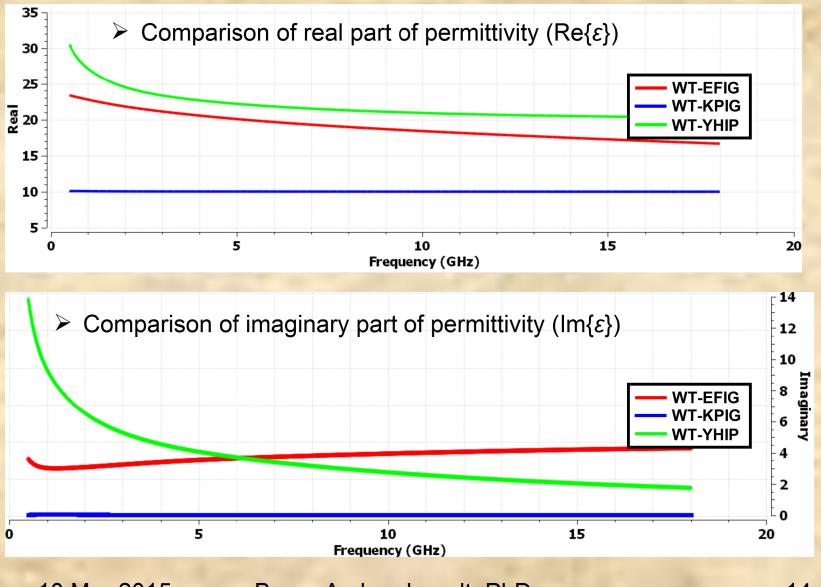
$$\mathcal{E} = (\mathcal{E}_r' + \mathcal{E}_r'') \mathcal{E}_0$$

$$\mu = (\mu_r' + \mu_r'') \mu_0$$

Single 'for phase delay

Double "for loss

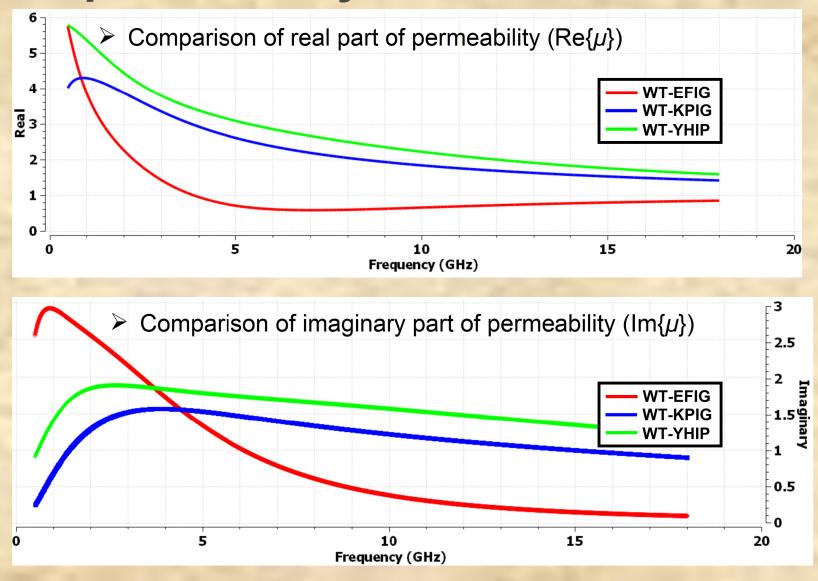
Example of Lossy Material EPS



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Example of Lossy Material Mu

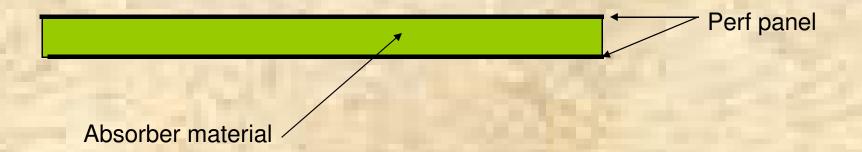


Using Lossy Materials

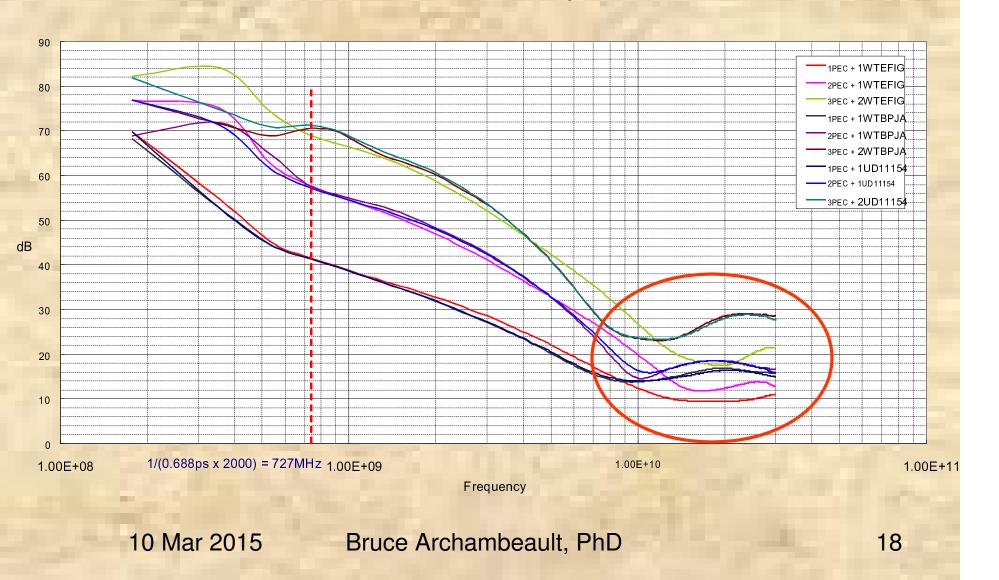
- With perforated panel air vents
- Under IC heatsinks
- Coating cables
- Resonant cavities

Lossy Material Sandwiched Between Perforated Panles

Edge View



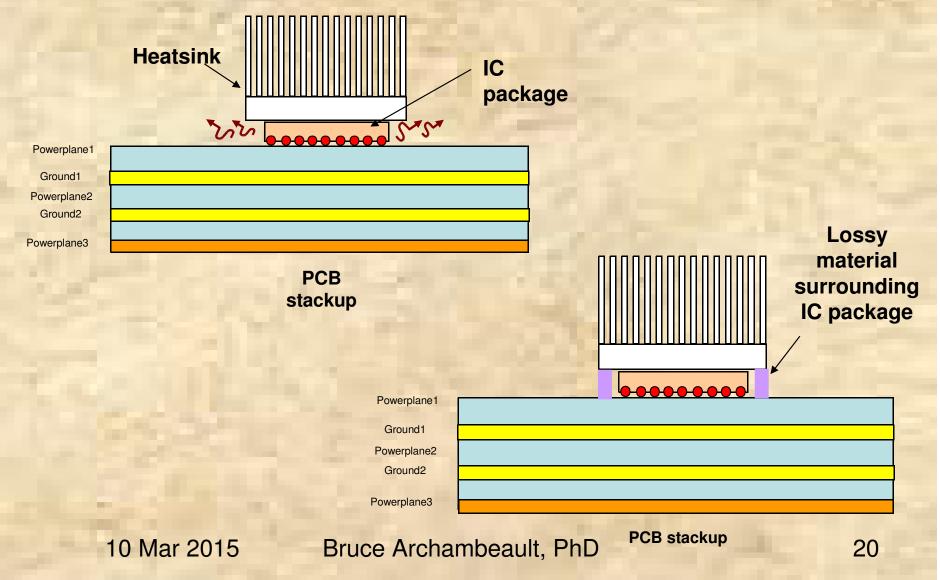
Shielded Air Vent with 3 Different Lossy Materials with 3 Different Stackup Structures



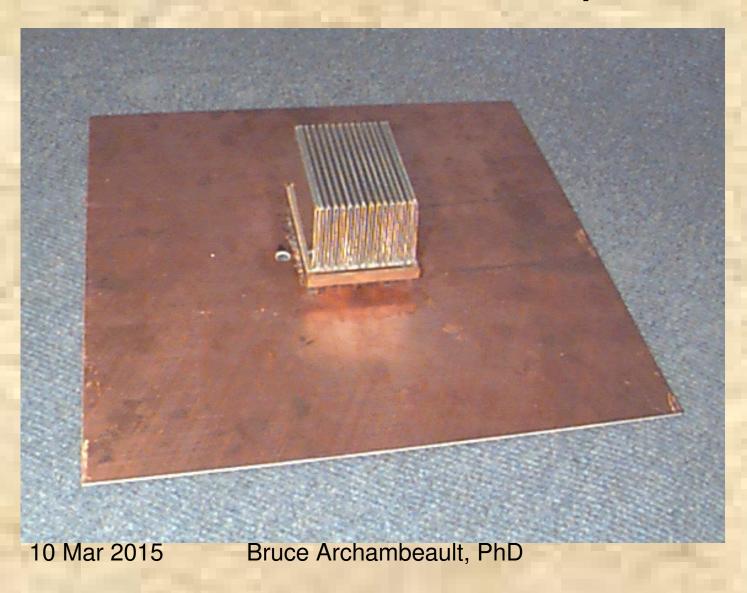
Heatsinks Can Increase Emissions

- Grounding heat sinks to PCB groundreference is commonly used to reduce heat sink emissions
 - Can actually <u>increase</u> emissions if not enough contact points!
 - Without continuous contact, improvement typically limited to < 3-5 GHz
- Lossy materials can make significant improvement at high frequency
 - Reverb chamber used for all measurements

Geometry

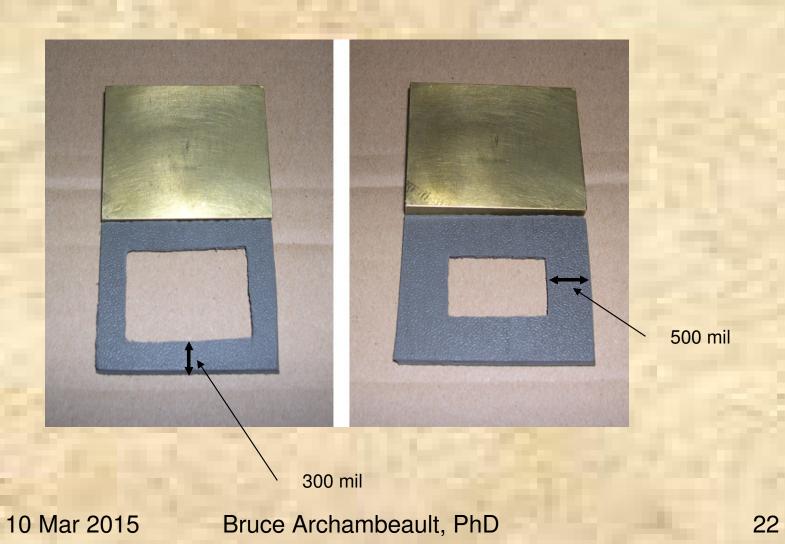


Test Fixture Example



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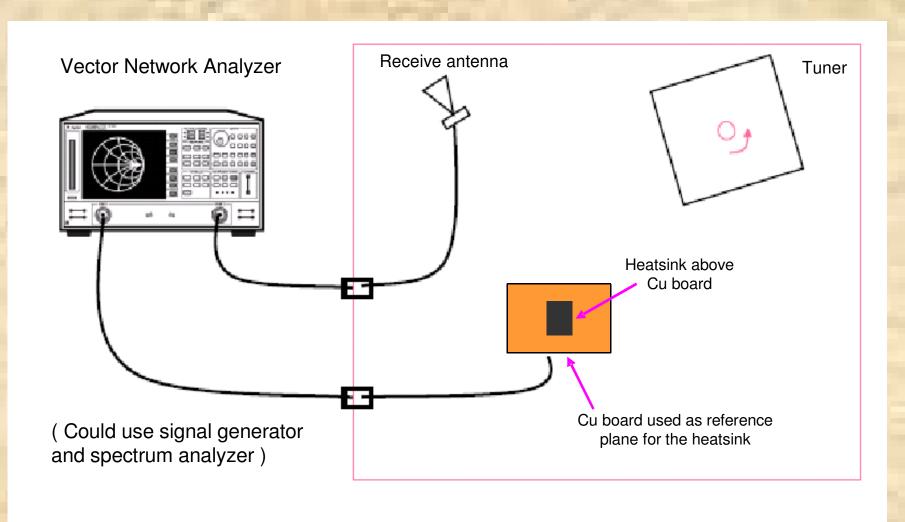
Lossy Material Cut into Square 'Donut'



Measurement Techniques

- Semi-anechoic chamber
 - Limited area where emissions are received
- Reverb Chamber
 - Capture emissions regardless of direction of propagation
 - Immune to test fixture size/length, position, configuration resonances

Test Set up in Reverb Chamber



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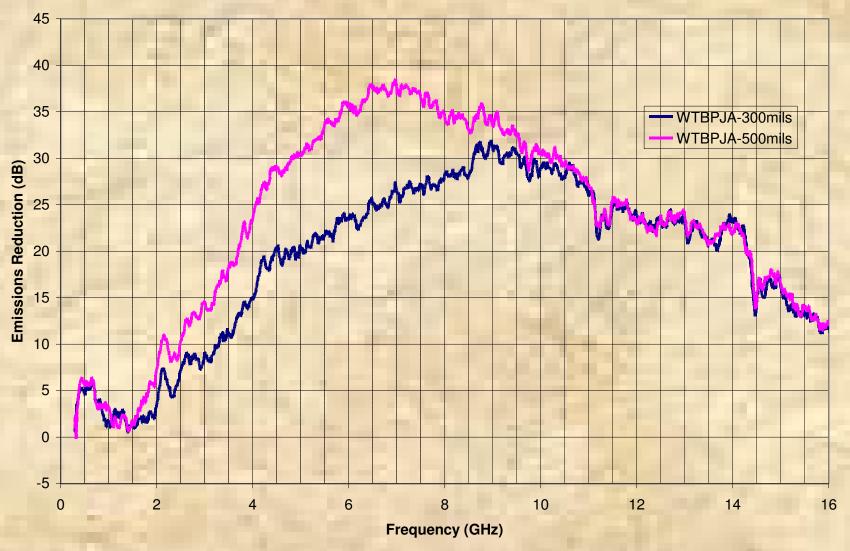
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Mode Stirrer



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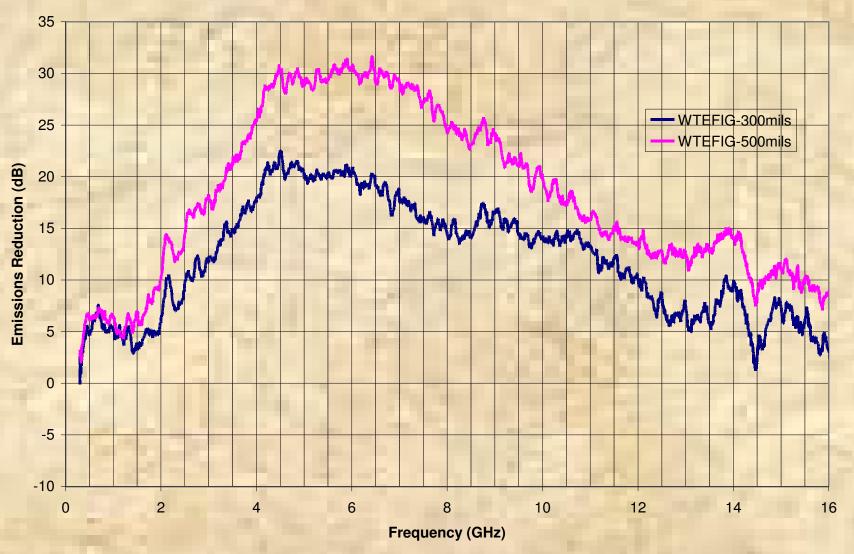
Emissions Reduction from Heatsink WT-BPJA Material



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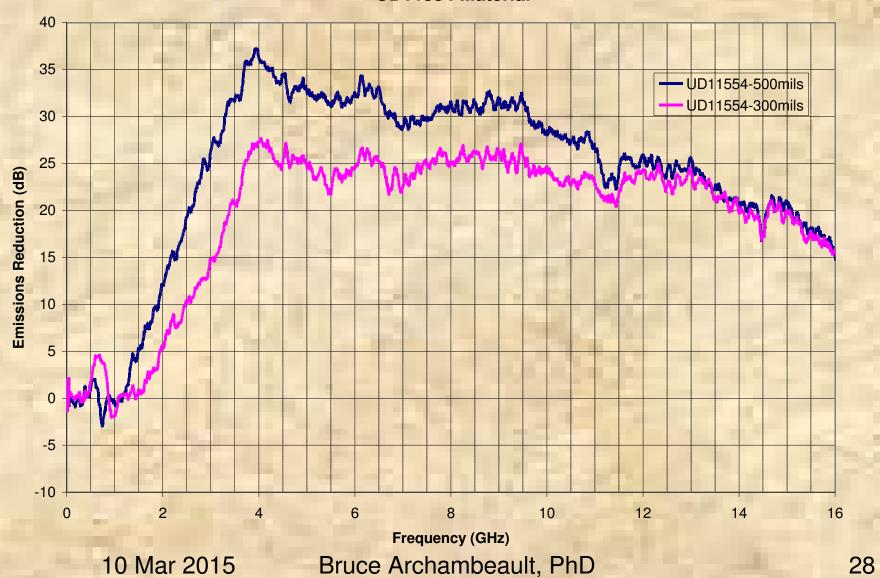
Emissions Reduction from Heatsink WT-EFIG Material



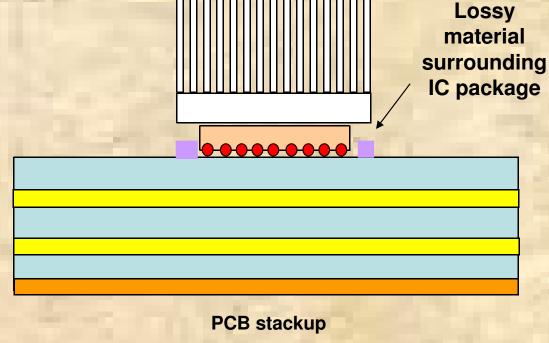
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Emissions Reduction from Heatsink UD11554 Material



UD11554 Material



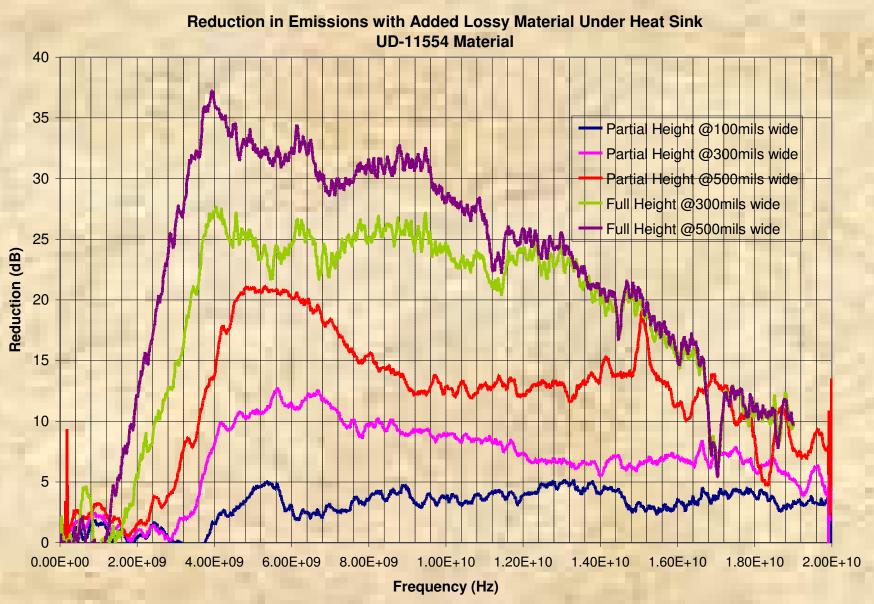
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Powerplane1

Ground1
Powerplane2
Ground2

Powerplane3

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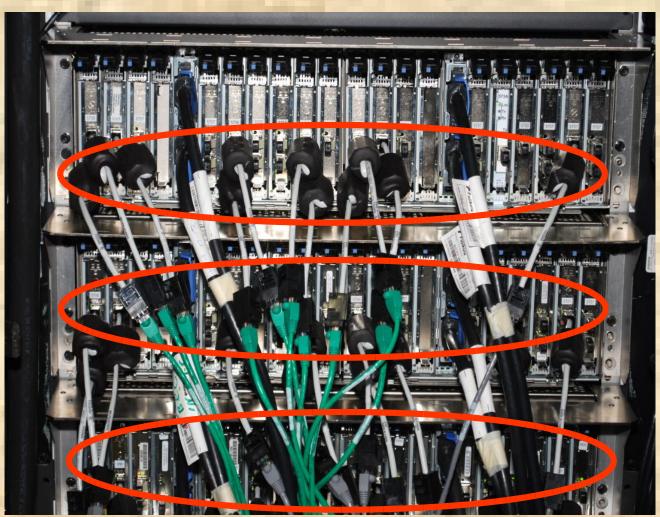
Heatsink Summary

- All materials reduce emissions above 3-4 GHz
- Wider material gives more loss
- Full height between heat sink and PCB give more loss than partial height

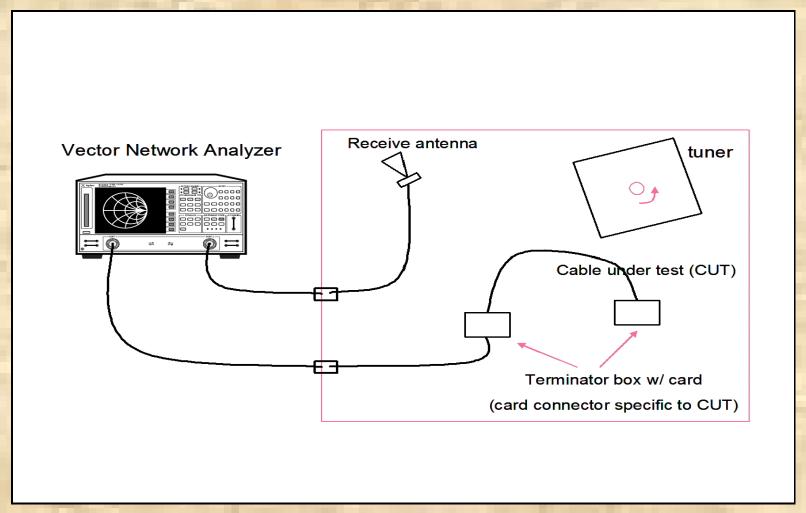
Emissions from Cables

- Often the largest emissions source from a system
- Often unshielded cables
 - High speed differential pairs (with common mode noise)
- Difficult to provide cost effective shielding at > GHz frequencies
- Lossy material examined to determine reduction in cable emissions

Motivation Eliminate Ferrite Cores on Cables



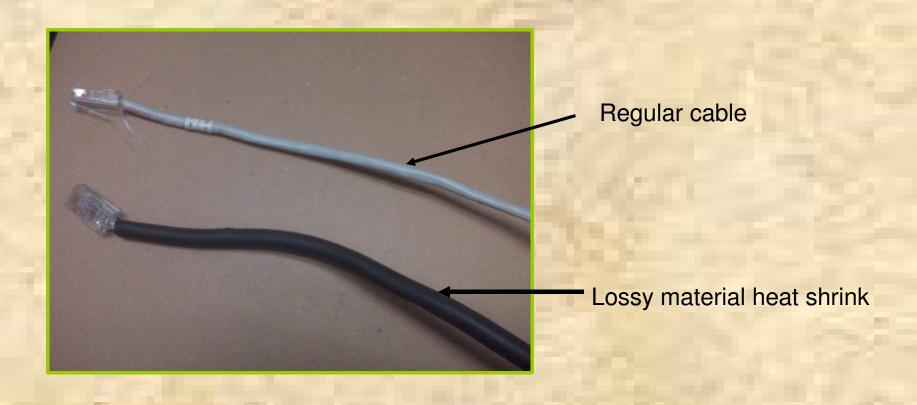
Reverb Chamber Test Configuration



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Ethernet Cable with and without Lossy Heat Shrink



Lossy Material Benefits

- Does not require a "water-tight" connection at connectors
 - Shielding requires complete coverage
- Potential to be extruded onto cable during cable manufacturing
 - Reduce cost

Partial Coverage Tests









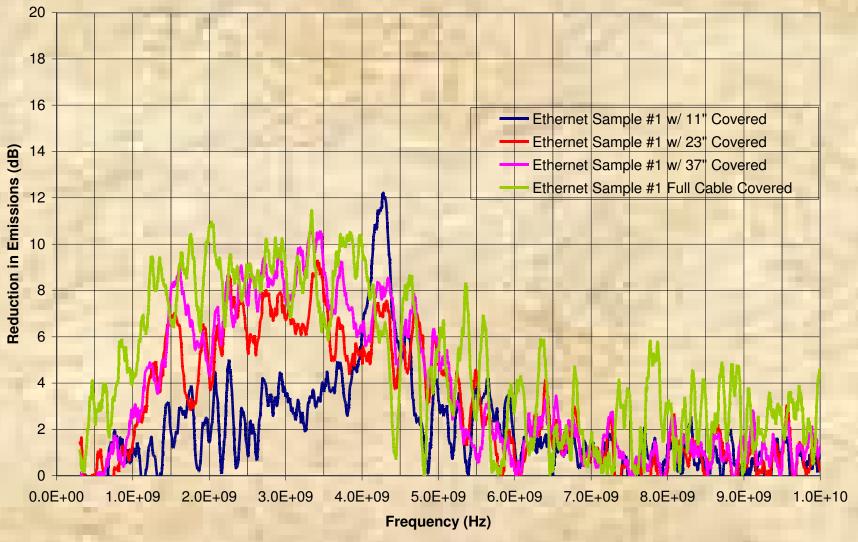
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Partial Coverage Tests

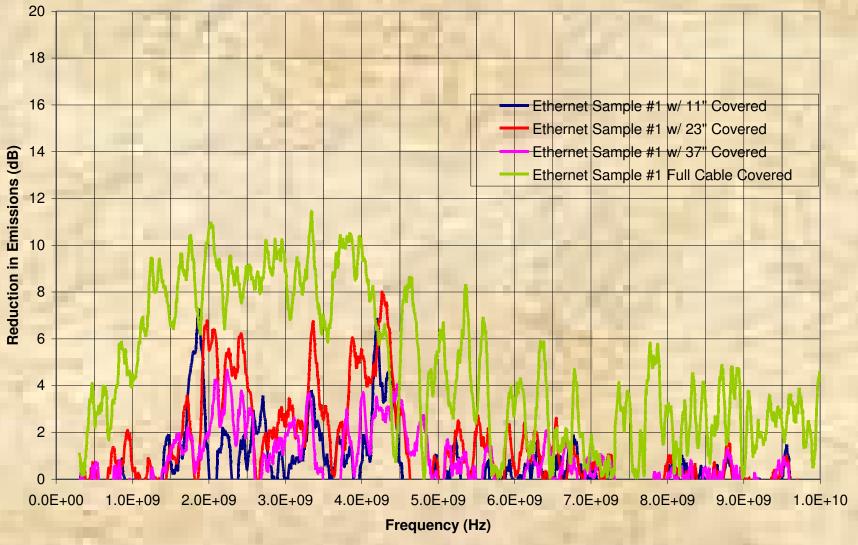
- Determine the effect of which end driven
 - End with lossy material
 - End w/o lossy material
- Determine the effect of not-full coverage
 - Cracks in material
 - Catastrophic in traditional shielding

Ethernet Cable Emission Reduction (When Drive Signal at Same End of Cable) ARC Lossy Material Covers Partial Length



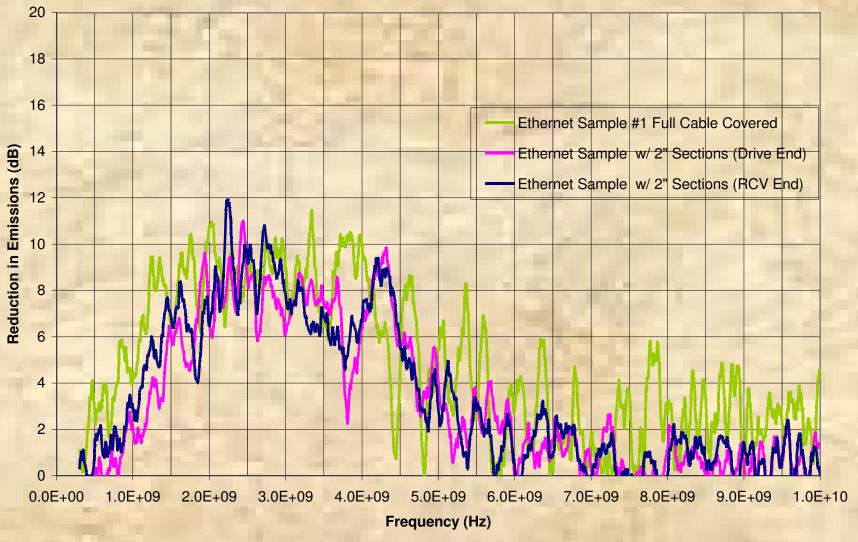
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Ethernet Cable Emission Reduction (When Drive Signal at Opposite End of Cable) ARC Lossy Material Covers Partial Length



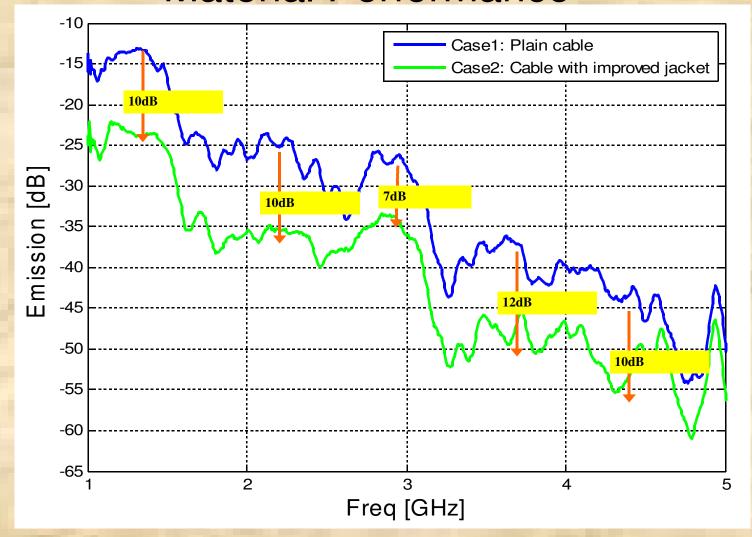
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Ethernet Cable Emission Reduction (When Drive Signal at Same End of Cable) ARC Lossy Material Covers Partial Length



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EMI Control for I/O Cables – Absorbing Material Performance



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Cable Summary

- Cables coated with lossy material reduces emissions from cables
- Full coverage not required
 - Effective at transmit end
- Compete (water tight) coverage not required
 - Cracks in lossy material not a concern as for traditional shielding

Reducing Resonance in Cavities

- Empty (or partially empty) enclosures allow standing wave resonant modes to be established
 - If dimensions are right...hard to predict in complex enclosures
- Empty metal box allows us to measure effect of various materials

Metal box photos



Fig 1a - Front view showing horizontal slot



Fig 1c - Inside view showing probe element

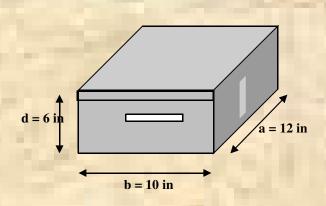


Fig 1b - Rear view showing veritcal slot



Fig 1d – Inside view showing application of ARC material 5

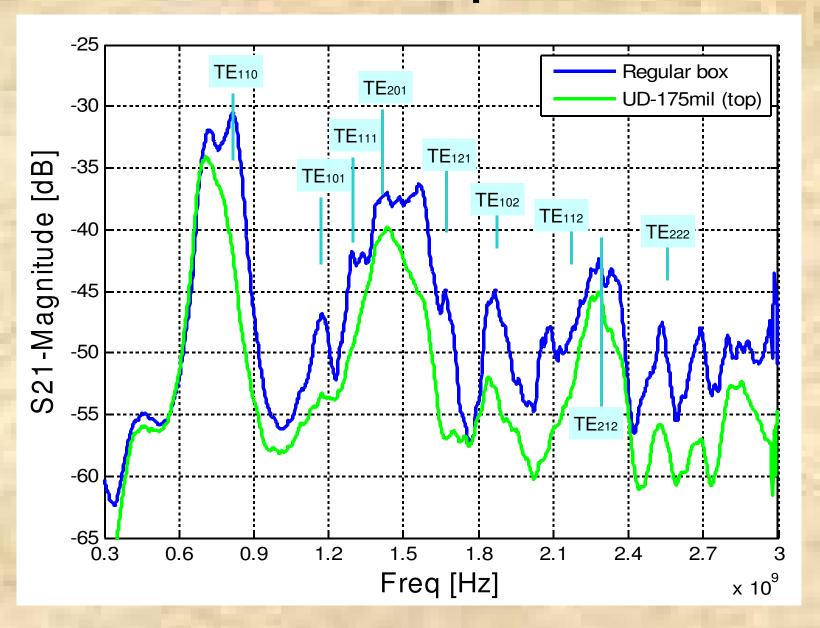
Metal box high order modes computation (up to 2.5GHz)



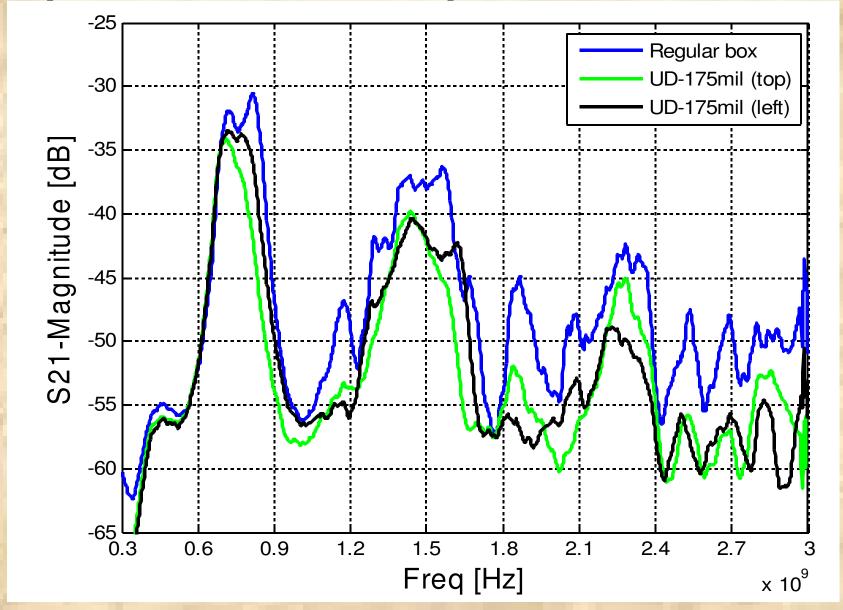
$$f = \frac{1}{2\sqrt{\mu\epsilon}}\sqrt{\left(\frac{m}{a}\right)^2 + \left(\frac{n}{b}\right)^2 + \left(\frac{l}{d}\right)^2}$$

Г							
	12 in	10 in	6 in	TE	(n,m,l)		FREQ [GHz]
	0.3048	0.254	0.1524	1	1	0	0.768725362
	0.3048	0.254	0.1524	1	0	1	1.100427154
	0.3048	0.254	0.1524	0	1	1	1.147825176
	0.3048	0.254	0.1524	-1	1	1	1.248875742
	0.3048	0.254	0.1524	2	0	1	1.391942483
	0.3048	0.254	0.1524	1	2	1	1.614293255
	0.3048	0.254	0.1524	1	0	2	2.029087414
	0.3048	0.254	0.1524	1	1	2	2.113278598
	0.3048	0.254	0.1524	2	1	2	2.278708052
	0.3048	0.254	0.1524	0	2	2	2.295650352
	0.3048	0.254	0.1524	2	2	2	2.497751484
L							

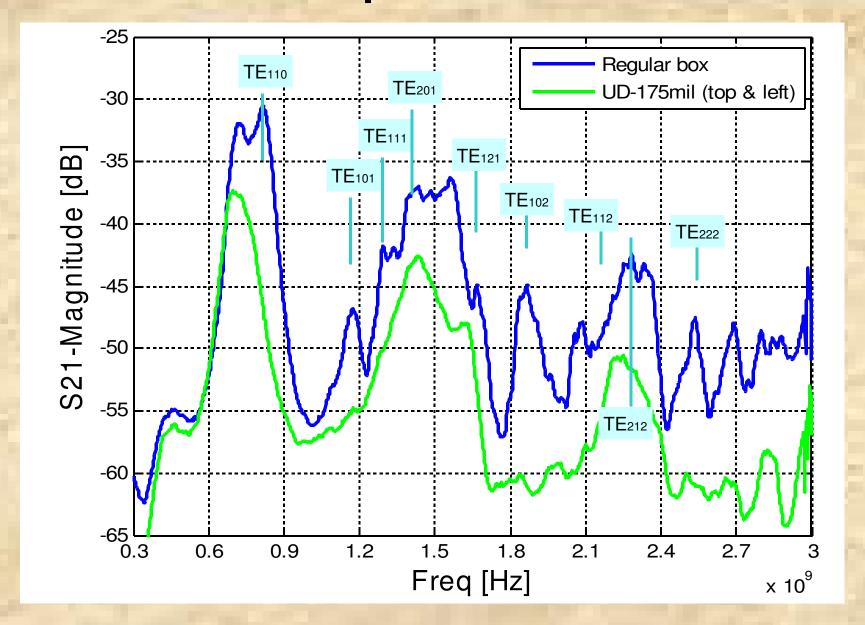
UD-175mil material on top-side



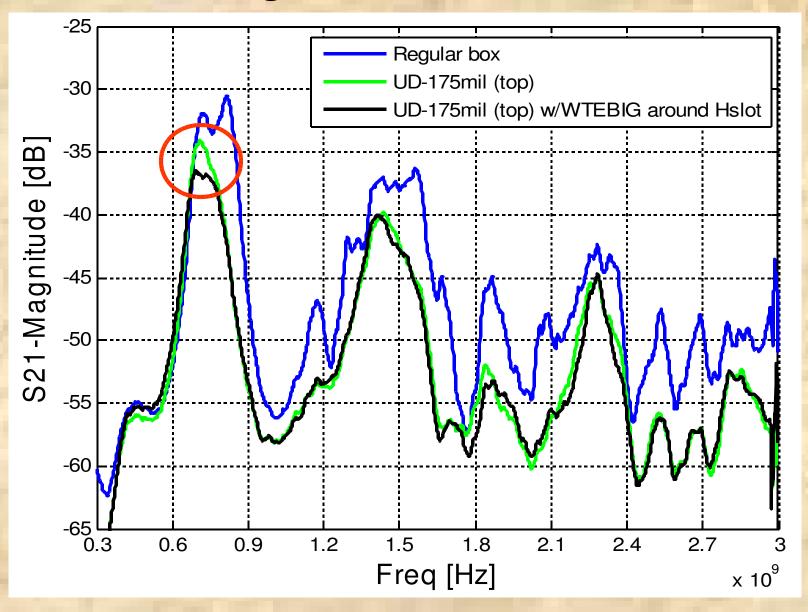
Top -vs- Left side comparison



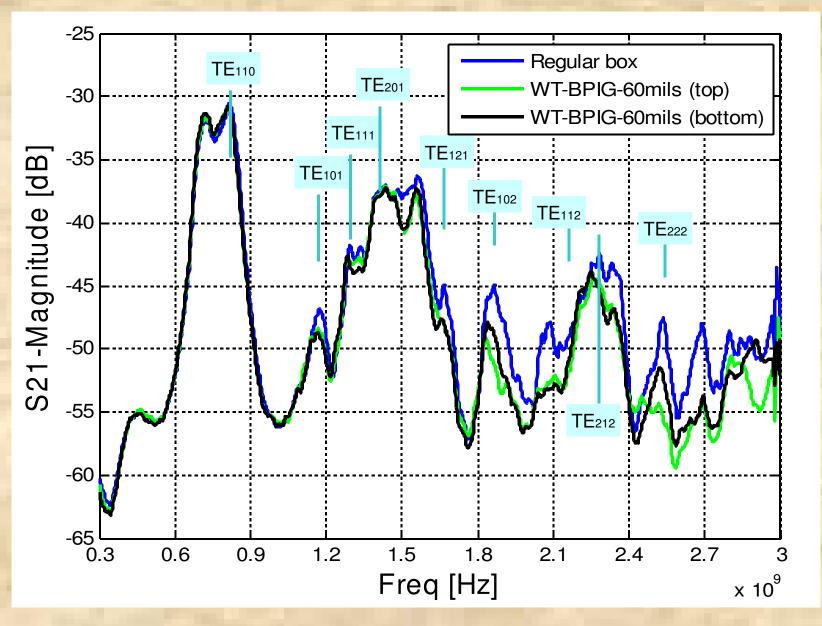
UD material on Top & Left sides



Effect of adding material around H-slot



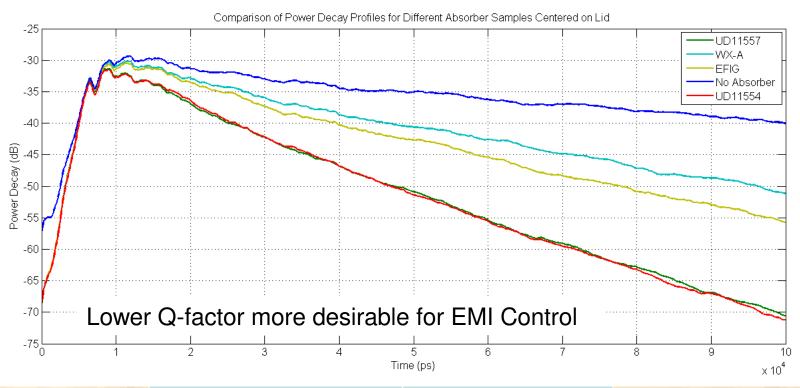
Effect of WT-BPIG material



Effects with Reverb Measurement

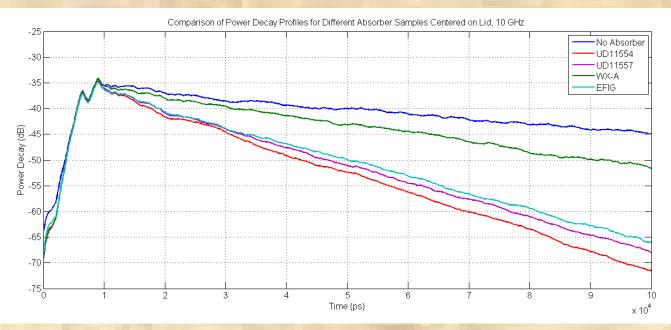
- Previous tests show effect w/o reverb within the box
 - Modes must be established before lossy material will have impact
- When reverb inside enclosure, then single port measurement allows Q-factor to be determined
 - Eliminates requirement for slot in box to allow energy out!
- Following slides courtesy of ARC Technology
 - David Green, "ONE-PORT TIME DOMAIN MEASUREMENT TECHNIQUE FOR QUALITY FACTOR ESTIMATION OF LOADED AND UNLOADED CAVITIES," IEEE EMC Symposium, August 2013, Denver

CENTER OF LID ABSORBER PLACEMENT – 3.5 GHZ CENTER FREQUENCY



	Cavity Setup	Measured Q (dB)	I liada a valana
	No Absorber	29.78	Higher slope
	UD11554	23.56	means more
COLUMN TO SERVICE STATE OF THE PARTY OF THE	UD11557	23.67	absorption/loss!
10 Mar 20	WX-A	26.45	53
TO War Ze	EFIG	25.54	

CENTER OF LID ABSORBER PLACEMENT – 10 GHZ CENTER FREQUENCY



	Cavity Setup	Measured Q (dB) 3.5 GHz	Measured Q (dB) 10 GHz
	No Absorber	29.78	34.62
	UD11554	23.56	28.57
	UD11557	23.67	29.03
	WX-A	26.45	32.07
I0 Ma	EFIG	25.54	29.33

54

Summary

- Traditional approaches to EM shielding at high frequencies will not work in practical products without excessive cost, weight, etc.
- Using lossy/absorbing materials allows designers to reduce EMC issues (emissions and immunity)
- Lossy/absorptive materials can be used
 - Under heatsinks
 - As coating to cables
 - To break cavity based resonances

Further Development Needed!

- Currently, it is difficult to predict effects of materials from simple material parameter analysis
- Full wave simulations with complex eps & mu are possible and on-going
- More work needed to allow relationship between complex eps & mu vs. frequency to help predict performance faster